Search Notes



10/798,047 Examiner

Christopher B. Shin

Applicant(s)/Patent under Reexamination

VANCE, JONATHAN

Art Unit

2	18	1	

	SEARCHED				
Class	Subclass	Date	Examiner		
709	220-226	7/5/2006	CBS		
710	8-13	7/5/2006	CBS		
717	168-178	12/5/2006	CBS		

Subclass	Date	Examiner
13	12/7/2006	CBS
220	12/7/2006	CBS
174	12/7/2006	CBS
	13 220	13 12/7/2006 220 12/7/2006

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS	7/5/2006	CBS		
PALM (DOUBLE PATENTING/INVENTOR)	7/5/2006	CBS		
EAST (EPO, JPO, USPGPUB, USPAT, DERWENT, IBMTDB, USOCR)	7/5/2006	CBS		
UPDATE -EAST	12/5/2006	CBS		